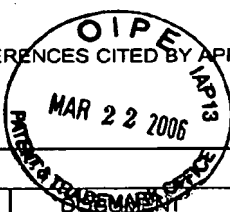


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 237054US0		SERIAL NO. New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Jean-Christophe SIMON et al.			
				FILING DATE Herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/MM/	AO	WO 02/078665	10/10/02	WIPO			
/MM/	AP	DE 196 43 773	04/30/98	GERMANY			XX
/MM/	AQ	2 815 848	05/03/02	FRANCE			XX
/MM/	AR	0 998 901	05/10/00	EUROPE			
/MM/	AS	2 823 103	10/11/02	FRANCE			XX
/MM/	AT	2 814 677	04/05/02	FRANCE			XX
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
/MM/	AW	DATABASE WPI; Derwent Publications Ltd., London, GB; AN 2002-073025; XP002246063 & KR 2001 069 807 A (Maglhtech); July 25, 2001					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Melissa Mercier/ (04/23/2007)		Date Considered	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 237054US0		SERIAL NO. 10/687,645	
LIST OF REFERENCES CITED BY APPLICANT 				APPLICANT Jean-Christophe SIMON, et al.			
				FILING DATE October 20, 2003		GROUP 1615	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/MM/	AA	2003/0118531 A1	06/26/2003	Richard KOLODZIEJ, et al.			
/MM/	AB	6,294,112 B1	09/25/2001	David A. CLARKE, et al.			
/MM/	AC	6,248,264 B1	06/19/2001	David A. CLARKE, et al.			
/MM/	AD	2002/0064509 A1	05/30/2002	Sabine GRIMM, et al.			
/MM/	AE	2004/0105827 A1	06/03/2004	Sabine GRIMM, et al.			
/MM/	AF	2001/0014341 A1	08/16/2001	Patricia LEMANN, et al.			
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
/MM/	AO	WO 02/36083 A1	05/10/2002	WIPO (with English Abstract and corr. US 2003/0118531 A1)		X	
/MM/	AP	2001-518893	10/16/2001	JAPAN (corr. US 6,294,112 B1)		X	
/MM/	AQ	2001-518926	10/16/2001	JAPAN (corr. US 6,248,264 B1)		X	
/MM/	AR	2001-518927	10/16/2001	JAPAN (with corr. WO 98/42695)			
/MM/	AS	WO 98/42695	10/01/1998	WIPO			
/MM/	AT	2002-154927	05/28/2002	JAPAN (corr. US 2002/0064509 A1)		X	
/MM/	AU	WO 02/28356 A1	04/11/2002	WIPO (with English abstract and corr. US 2004/0105827 A1)		X	
/MM/	AV	10-72317	03/17/1998	JAPAN (corr. US 2001/0014341 A1)		X	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Melissa Mercier/ (04/23/2007)					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
237054US0SERIAL NO.
10/687,645

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Jean-Christophe SIMON, et al.FILING DATE
October 20, 2003GROUP
1712

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/MM/	AA	2002/0122780	09/05/02	McManus, et al.			
/MM/	AB	6,080,415	06/27/00	Jean-Christophe Simon			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/MM/	AO	FR 2 814 677	04/05/02	France (English Abstract Provided)		X
/MM/	AP	EP 0 847 751	06/17/98	EPO (English Abstract Provided)		X
/MM/	AQ	EP 0 665 008	08/02/95	EPO (English Abstract Provided)		X
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner /Melissa Mercier/ (04/23/2007)

Date Considered

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.